

Sheet 1 of 1

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE
(Rev. 2-32) PATENT AND TRADEMARK OFFICEINFORMATION DISCLOSURE
STATEMENT BY APPLICANT

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ATTY. DOCKET NO.
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APPLICANT

Mark G. Torchia, et al.

FILING DATE
November 5, 2003

GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/AF/	4,671,254	08/09/1987	Fair	801/3		03/01/1985
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DOCUMENT NUMBER	DATE	COUNTRY / NAME	CLASS	SUBCLASS	TRANSLATION
/AF/ WO/9852465	1998/11/26	PCT			YES
EP 614651 A1	1994/09/14	Europe			YES

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/AF/	Kahn, et al. in Journal of Computer Assisted Tomography 18(4):519-532, July/August 1994
	Kahn, et al. in Journal of Magnetic Resonance Imaging 8: 160-164, 1998
	Vogl, et al. in Radiology 209: 381-385, 1998

EXAMINER

/Ahmed Farah/ (03/19/2007)

DATE CONSIDERED

03/19/2007

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.